Test Equipment Solutions Datasheet

Test Equipment Solutions Ltd specialise in the second user sale, rental and distribution of quality test & measurement (T&M) equipment. We stock all major equipment types such as Spectrum Analyzers, Signal Generators, Oscilloscopes, Power Meters, Network Analyzers etc from all the major suppliers such as Keysight, Tektronix, Anritsu and Rohde & Schwarz.

We are focused at the professional end of the marketplace, primarily working with customers for whom high performance, quality and service are key, whilst realising the cost savings that second user equipment offers. We fully test & refurbish equipment in our in-house, traceable Lab. Items are supplied with manuals, accessories and typically a full no-quibble 1 year warranty. Our staff have extensive backgrounds in T&M which enables us to deliver industry-leading service and support. We endeavour to be customer focused in every way right down to the detail, such as offering free delivery on sales, presenting flexible technical + commercial solutions and supplying a loan unit during warranty repair, if available.

As well as the headline benefit of cost saving, second user offers shorter lead times, higher reliability and multivendor solutions. Rental, of course, is ideal for shorter term needs and offers fast delivery, flexibility, try-before-you-buy, zero capital expenditure, lower risk and off balance sheet accounting. Both second user and rental improve the key business measure of Return On Capital Employed.

We are based in at Oakley, Bedfordshire in the UK from where we supply test equipment worldwide. Our facility incorporates Sales, Support, Admin, Logistics and our own in-house Lab.

All products supplied by Test Equipment Solutions include:

- No-quibble parts & labour warranty (we provide transport for UK mainland addresses).
- Free loan equipment during warranty repair, if available.
- Full electrical, mechanical and safety refurbishment in our 40GHz in-house Lab.
- Certificate of Conformance (calibration available on request).
- Manuals and accessories required for normal operation.
- Free insured delivery to your UK mainland address (sales).
- Support from our team of seasoned Test & Measurement engineers.
- ISO9001 quality assurance.

Test Equipment Solutions Ltd Unit 3 Highfield Court Highfield Road Oakley Bedfordshire MK43 7TA

Telephone: 01183 800 800

Email: info@TestEquipmentHQ.com Web: www.TestEquipmentHQ.com







7200 Series Capacitance Meter

The 7200 is a sophisticated capacitance meter equally suited for demanding R&D, as well as manufacturing applications. Two phase-sensitive detectors are used to extract and display both the parallel capacitance and conductance of the device under test. From the measured parameters the 7200 can calculate and display the equivalent parallel and series resistance, series capacitance, dissipation factor, and quality factor Q. Capacitance can also be displayed as a deviation from a selectable reference standard in % or pF units. The 7200 uses a software filter technique which averages consecutive measurements to achieve a stable display value. Test levels are programmable from 15 to 100 mV, making the 7200 suitable for a wide variety of semiconductor measurements. Up to 99 complete front panel setups can be stored and recalled in internal non-volatile memory.

Bias Voltage

The 7200 accepts, measures and displays external bias voltage over a range of ± 60 V. An internal bias supply is also included and is programmable over a ± 60 V range. This bias capability, along with fast responding analog C, G and V outputs, makes the 7200 ideal for C-V and G-V semiconductor plots, as well as DLTS material studies.

Automatic Zeroing

One key stroke zeros the 7200 for stray capacitance and loss. The 7200 is capable of zeroing up to 2000 pF. As a result, the maximum range of the instrument can be effectively increased to 4000 pF by first zeroing the 7200 with a 2000 pF specimen connected to the input.

Special Functions

A variety of special functions are provided to extend the operation of the 7200 to meet specific requirements. For example, the instrument can be forced to hold a particular measurement or bias range. The averaging filter length can be selected from no averaging up to 500 measurements. Special functions can also be used, in conjunction with external standards, to calibrate the instrument from the front panel or over the IEEE-488 interface.



- Capacitance range, 0 to 2000 pF
- Conductance range, 0 to 2000 μS
- Test frequency, 1 MHz crystal-controlled
- Test level, selectable 15, 30, 50, and 100 mV
- External bias ±60 V
- Standard programmable internal bias ±60 V
- Analog outputs proportional to both C and G and bias
- GPIB standard

Bus Operation

The 7200 is equipped with a full function IEEE-488 interface bus. The following can be remotely programmed: all panel functions, including special functions; store and recall panel setups; and zero and bias controls. For rapid data transfer, C, G and V information is available simultaneously. Front panel setups can be stored and recalled by program location.

Specifications

Maximum current

Capacitance Display		External Bias Display	
Capacitance Range	0 to 2000 pF	Voltage Range	±60 V
Full Scale Ranges	2, 20, 200, 2000 pF	Resolution	0.1 V
Accuracy	0.25% of reading	Accuracy	0.25% of rdg + 4 counts
	+0.2% of full scale +0.005 pF		
Resolution	0.001 pF from 0 to 2 pF	Internal Bias	
	0.01 pF from 2 to 20 pF	Voltage Range	±60 volts, programmable from
	0.1 pF from 20 to 200 pF		the front panel
	1 pF above 200 pF	Accuracy	0.5% of setting + 10 counts
		Resolution	1 mV for voltages ≤ 20 V
Conductance Display			10 mV for voltages > 20 V
Conductance Range	0 to 2000 μS	Maximum Current	5 mA
Full Scale Ranges	2, 20, 200, 2000 μS	./.	
Accuracy		Rear Panel Connectors	
2.5% of reading +2.0% of full	l scale +0.05 μS + 2 (ωC)²	Analog Out, C	2 volts full scale, source resis-
Where C is the parallel capaci	tance in Farads	Oll Sales	tance 1000 ohms, linearity 0.1
Residual Series Resistance	2Ω maximum	2ent on	of reading + 0.05% of full scale
Resolution	0.01 μS from 0 to 2 μS	Analog Out, G	2 volts full scale, source resis-
	0.1 μS from 20 to 20 μS	Eale entit	tance 1000 ohms, linearity 0.1
	1 μS from 20 to 200 μS	got silphi	of reading + 0.05% of full scale
	10 μS above 200 μS	Analog Out, Bias	2 volts full scale
	42	ipril Les	Source resistance 1000 ohms
Computed Parameters		Analog Out, Bias	Complies with IEEE-488-1978
Series Capacitance	0.000 to ±9999 pF 0.00 Ω to ±9.999 MΩ ±488.5 Ω to ±9.999 MΩ 0.000 to ±999.9	External Bias In	Implements AH1, SH1, T6, TEO,
Series Resistance	0.00 Ω to ±9.999 MΩ	C.co.	L4, LEO, SR1, RL1, PPO, DC1, DT
Parallel Resistance	±488.5 Ω to ±9.999 MΩ	nithe	CO and E1
Dissipation	0.000 to ±999.9	External Bias In	±60 volts max
Quality Factor	0.000 to ±999.9		62.5 mA fuse protected
ΔC	0.000 to ±4047 pF		
Δ%	0.00 to ±99.99%	Front Panel Controls and Dis	plays
	in.	Controls	Keyswitches enable data entry
Temperature Influences			and selection of major function
Operating Temperature	10° C to 40° C	Displays	Vacuum Fluorescent
Amplitude Error	<± 0.017% /° C		20-digit display of BIAS LEVEL,
Phase Error	<± 0.2° /° C		TEST LEVEL, CAPACITANCE, LOSS
Warmup Time	2 Hours		ADRS AND SPCL
Test Signal			
Frequency	1.0 MHz, crystal-controlled		
Level	Programmable		
	15, 30, 50 and 100 mV		
External Piec			
External Bias Voltage Range	±60 V		
	±		

62.5 mA fuse protected

Other Specifications

Weight	12 lbs (5.4 kg)	
Power Requirements	100, 120, 220, 240 V AC	
	50-60 Hz, 35 VA	

Council Directives

89/336/EEC//93/68/EEC, 73/23/EEC//93/68/EEC & Standards EN55011, EN50082-1, EN61010-1

CE Mark Declares Conformity to European Community (EC)

Accessories

Rack mount kit, single	PIN 950002
Rack mount kit, dual	PIN 950001





Wireless Telecom Group Inc.

25 Eastmans Rd Parsippany, NJ United States

Tel: +1 973 386 9696 Fax: +1 973 386 9191 www.boonton.com

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B/7200/1010/EN Note: Specifications, terms and conditions are subject to change without prior notice.

